

P.K. Rastogi (Ed.)

Holographic Interferometry

Principles and Methods

With 178 Figures, Some in Colour

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Contents

1	Introduction	
P.K. Rastogi	1	
References	6	
2	Basic Principles	
P. Hariharan. With 18 Figures	7	
2.1 The Development of Holography	7	
2.2 The Off-Axis Hologram	9	
2.2.1 Reflection Holograms	11	
2.2.2 Image Holograms	11	
2.3 The Reconstructed Image	12	
2.4 Image Speckle	13	
2.4.1 Signal-to-Noise Ratio	14	
2.5 Types of Holograms	14	
2.5.1 Thin Amplitude and Phase Gratings	14	
2.5.2 Volume Gratings	15	
2.5.3 Holograms of Diffusely Reflecting Objects	18	
2.5.4 Multiply Exposed Holograms	18	
2.6 Light Sources and Optical Systems	19	
2.6.1 Coherence Requirements	19	
2.6.2 Laser Beam Expansion	20	
2.6.3 Beam Polarization	21	
2.6.4 Optical Systems for Holography	21	
2.6.5 Holography with Pulsed Lasers	22	
2.6.6 Laser Safety	22	
2.7 The Recording Medium	22	
2.7.1 Effects of Nonlinearity	24	
2.8 Recording Materials	24	
2.8.1 Photographic Emulsions	25	
2.8.2 Photothermoplastics	25	
2.8.3 Photorefractive Crystals	26	
2.9 Holographic Interferometry	27	
2.9.1 Real-Time Holographic Interferometry	27	
2.9.2 Double-Exposure Holographic Interferometry	28	
2.9.3 Phase Difference in the Interference Pattern	29	

2.9.4	The Holodiagram	30
2.9.5	Localization of the Interference Fringes	31
	References	31
3	Quantitative Determination of Displacements and Strains from Holograms	
	R.J. Pryputniewicz. With 19 Figures	33
3.1	Projection matrices: Definition and properties.....	33
3.1.1	Normal Projection	33
3.1.2	Oblique Projection	35
3.2	Illumination, Observation, and Sensitivity Vectors.....	38
3.3	Determination of Displacements	39
3.3.1	Determination of Displacements when Fringe Order is Known	41
3.3.2	Determination of Displacements when Fringe Order is Unknown.....	47
3.3.3	Determination of Displacements from Multiple Holograms	51
3.4	Determination of Strains and Rotations	53
3.4.1	Spatial Dependence of the Fringe-Locus Function	56
3.4.2	Rigid-Body Rotations and Homogeneous Strains	57
3.5	Electro-Optic Holography.....	59
3.5.1	Fundamentals of EOH	59
3.5.2	Electronic Processing of Holograms	60
3.5.2.1	Static Measurements	60
3.5.2.2	Dynamic Measurements	64
3.5.3	Representative Applications of EOH.....	68
3.6	Conclusions.....	70
	References	72
4	Two-Reference-Beam Holographic Interferometry	
	R. Dändliker. With 22 Figures.....	75
4.1	Electronic Interference Phase Measurement.....	75
4.1.1	Phase-Shifting and Heterodyne Detection	76
4.1.2	Double-Exposure with Two Reference Beams.....	78
4.2	Interferometry with Speckle Fields (Diffusely Scattering Objects)	82
4.2.1	Speckle Statistics for Coherent Imaging	83
4.2.2	Measuring Intensity with a Detector of Finite Size	84
4.2.3	Interference Fringe Formation	86

	Contents	IX
4.3 Sources of Errors in Interference Phase Measurement	88	
4.3.1 Systematic Errors from Holographic Interferometry with Two Reference Sources	88	
4.3.1.1 Misalignment of Hologram and Reconstructing Reference Waves	88	
4.3.1.2 Cross-Talk from Holographic Recording	89	
4.3.1.3 Spurious Fringes Due to Overlapping Reconstructions	90	
4.3.2 Statistical Errors Due to Speckle Noise	90	
4.3.2.1 Non-Overlapping Reconstructions	91	
4.3.2.2 Overlapping Reconstructions	94	
4.4 Applications	95	
4.4.1 Double-Exposure Holography with Phase-Shift Fringe Evaluation	95	
4.4.2 Multiple-Exposure Holographic Interferometry	98	
4.4.3 Double-Pulse Holography for 3-D Displacement Measurement	99	
4.4.4 Strain Measurement by Heterodyne Holographic Interferometry	102	
4.5 Conclusions	106	
References	107	

5 Phase-Shifting Holographic Interferometry

K. Creath. With 23 Figures	109	
5.1 Background	109	
5.1.1 Real-Time Holographic Secondary Interference Fringes	109	
5.1.2 From Wavefront to Object Displacement	110	
5.2 Phase-Measurement Basics	111	
5.2.1 General Phase Measurement Theory	112	
5.2.2 Phase-Modulation Techniques	114	
5.2.3 Phase Unwrapping	116	
5.2.4 Sampling Requirements	117	
5.2.5 Intensity-Modulation Requirements	119	
5.2.6 Measurement Examples	121	
5.3 Temporal Phase-Measurement (Phase-Shifting) Algorithms	122	
5.3.1 Three Frames (90° , 120° , and General Phase Shifts)	122	
5.3.2 Four Frames (90° Phase Shifts)	123	
5.3.3 Five Frames (90° Phase Shifts)	124	
5.3.4 Carré (Four Frames with General Phase Shifts)	125	
5.3.5 Synchronous Detection ($2\pi/N$ Phase Shifts)	125	
5.3.6 ($N + 1$) Frames ($2\pi/N$ Phase Shifts)	126	

5.3.7	2 + 1 (90° Phase Shifts)	126
5.3.8	Scanning Phase Shift (Random Phase Shifts)	127
5.4	Phase-Shifter Calibration	128
5.5	Major Error Sources	130
5.5.1	Phase-Shifter Errors	132
5.5.2	Detection (Intensity) Nonlinearities	134
5.5.3	Quantization	136
5.5.4	Vibration and Air Turbulence	137
5.6	Equipment and Experimental Consideration	139
5.6.1	Cameras and Frame Grabbers	139
5.6.2	Phase Shifters: Ramping Versus Stepping	141
5.6.3	Alignment Considerations	142
5.7	Specialized Techniques	142
5.7.1	Electronic Holography	142
5.7.2	Time-Average Vibration Analysis	144
5.7.3	Phase-Shifting Holographic Moiré	145
5.8	Emerging Trends	147
	References	148
6	Computer-Aided Evaluation of Holographic Interferograms	
	T. Kreis. With 27 Figures	151
6.1	Background	151
6.1.1	Holographic Interferometry	151
6.1.2	Digital Image Processing	153
6.2	Fringe Formation in Holographic Interferometry	155
6.2.1	Double Exposure and Real-Time Holographic Interferometry	155
6.2.2	Vibration Analysis by Holographic Interferometry	156
6.2.3	Interference Phase Variation due to Deformation	157
6.2.4	Interference Phase Variation due to Refractive-Index Variations	159
6.2.5	Ambiguity of Fringe Patterns	160
6.2.6	Distortions of Holographic Interferograms	163
6.2.7	Simulation of Holographic Interference Patterns	163
6.3	Evaluation of Holographic Interferograms	164
6.3.1	Qualitative Evaluation	164
6.3.2	Quantitative Evaluation	165
6.3.3	Condition of the Evaluation Matrix	168
6.3.4	Determination of Sensitivity Vectors	169
6.3.5	Correction of Perspective Distortion	170
6.4	Interference Phase Determination	173
6.4.1	Fringe Skeletonizing	173
6.4.2	Evaluation by Temporal Heterodyning	175

6.4.3	Phase-Sampling Evaluation	177
6.4.3.1	Phase Shifting and Phase Stepping.	178
6.4.3.2	Solution of Phase Sampling Equation	179
6.4.3.3	Phase Sampling with Unknown Phase Steps	180
6.4.4	Fourier-Transform Evaluation	184
6.4.4.1	Spatial Heterodyning	184
6.4.4.2	Fourier-Transform Evaluation Without Carrier	185
6.4.4.3	Fourier-Transform Evaluation of Phase Shifted Interferograms	192
6.4.5	Further Methods for Interference Phase Determination	193
6.4.6	Interference Phase Demodulation.	195
6.4.7	Comparison of Interference Phase Determination Methods	197
6.4.7.1	Experimental Requirements	197
6.4.7.2	Resolution and Precision.	199
6.4.7.3	Errors and Distortions.	200
6.4.7.4	Comparison Results	200
6.5	Processing of Evaluated Data	201
6.5.1	Curve Fitting by Gaussian Least Squares	201
6.5.2	Strain and Stress Analysis.	204
6.5.3	Finite-Element Methods	205
6.5.4	Boundary-Element Methods	206
6.5.5	Fracture Mechanics	206
6.5.6	Computer Tomography.	207
6.6	Conclusions and Future Trends.	208
	References	209

7 Techniques to Measure Displacements, Derivatives and Surface Shapes.

Extension to Comparative Holography

P.K. Rastogi. With 62 Figures	213	
7.1	Measurement of Out-of-Plane Displacements	214
7.1.1	Basic Configurations	214
7.1.1.1	Remarks on the Removal of Phase Ambiguities and Measurement of Small Deformations.	217
7.1.2	Speckle Decorrelation and Fringe Visibility	218
7.1.3	Compensation of Rigid-Body Movements and Fringe Control.	220
7.2	Measurement of In-Plane Displacements	221
7.2.1	Holographic Moiré.	222
7.2.1.1	Basic Relations	222
7.2.1.2	Generation of Auxiliary Fringes	224

7.2.1.3	Localization	226
7.2.1.4	Some Remarks Concerning Imaging Parameters	229
7.2.2	Reconstructed Reference Wave Holographic Interferometry	230
7.2.3	Conjugate-Wave Holographic Interferometry	232
7.2.4	Phase-Shifted Holographic Moiré	233
7.3	Measurement of the Derivatives of Displacements	236
7.3.1	Measurement of Slope Change and Curvature	238
7.3.1.1	Holographic Moiré for Slope-Change Measurement	238
7.3.1.2	Measurement of Curvature	243
7.3.1.3	Measurement of Slope and Curvature using Modulated Diffraction Gratings	249
7.3.1.4	Relationship between the Second Derivatives, Moments and Stresses	251
7.3.2	Measurement of In-Plane Strains	252
7.3.2.1	Measurement of In-Plane Strains using Modulated Diffraction Gratings	252
7.4	Contouring of Three-Dimensional Objects	254
7.4.1	Wavelength-Difference Contouring	255
7.4.2	Immersion Method	257
7.4.3	Holographic Moiré Multiple-Sources Contouring	258
7.4.3.1	Basic Technique	258
7.4.3.2	Phase Management Solution	260
7.4.3.3	Mechanism of Fringe Formation	263
7.4.3.4	Performance Evaluation	264
7.4.4	Holographic Moiré Object Tilt Contouring	266
7.4.5	Multiple-Sources Contouring	268
7.4.5.1	Basic Techniques	268
7.4.5.2	Mechanism of Fringe Formation	270
7.4.5.3	Enhancement of Contouring Sensitivity	271
7.4.5.4	Orientation of the Contour Planes	274
7.5	Comparative Holographic Interferometry	274
7.5.1	Equation of the Difference Displacement Vector of Two Surface Elements	275
7.5.2	Difference Holographic Interferometry	277
7.5.3	Comparative Holographic Moiré	280
7.5.4	Formation of the Modulated Pattern	282
7.5.5	Phase-Shifted Comparative Holography	285
7.6	Conclusions	288
	References	288

8 Study of Vibrations	
C.S. Vikram. With 9 Figures	293
8.1 Time-Average Holographic Interferometry of Sinusoidal Vibration and Separable Motions.....	293
8.2 Real-Time Interferometry of Vibration	295
8.3 Time-Average Holography of Nonseparable Motions and Multiple Modes	296
8.4 Stroboscopic Holographic Interferometry.....	298
8.5 Temporally Modulated Holography.....	301
8.5.1 Frequency Translation.....	302
8.5.2 Amplitude Modulation	302
8.5.3 Laser Irradiance Modulation.....	303
8.5.4 Phase Modulation	303
8.5.5 Holographic Subtraction.....	305
8.5.6 Other Modulation Techniques	306
8.6 Fringe-Shifting and Quantitative Analysis Techniques	306
8.7 Rotating Objects	311
8.7.1 Synchronized Triggering	312
8.7.2 Rotating Holographic Plate and Reference Beam	312
8.7.3 Use of Image-Derotator	312
8.8 Other Techniques and Applications	312
References	316
Subject Index.....	319